

MTD1N80E-VB Datasheet N-Channel 800V (D-S) Super Junction Power MOSFET

| PRODUCT SUMMARY | | | | |
|--|------------------------|------|--|--|
| V _{DS} (V) at T _J max. | 800 | | | |
| R _{DS(on)} typ. (Ω) at 25 °C | V _{GS} = 10 V | 2.38 | | |
| Q _g max. (nC) | 90 | | | |
| Q _{gs} (nC) | 11 | | | |
| Q _{gd} (nC) | 19 | | | |
| Configuration | Single | | | |

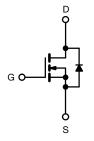
FEATURES

- Low figure-of-merit (FOM) Ron x Qq
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)









N-Channel MOSFET

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | | |
|--|-------------------------|---|-----------------------------------|-------------|--------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-source voltage | | | V_{DS} | 800 | V | |
| Gate-source voltage | | | V_{GS} | ± 30 | 7 | |
| Continuous drain current (T _J = 150 °C) | V at 10 V | $T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$ | - I _D | 2.8 | | |
| | V _{GS} at 10 V | T _C = 100 °C | | 1.8 | Α | |
| Pulsed drain current ^a | | | I _{DM} | 5 | | |
| Linear derating factor | | | | 0.5 | W/°C | |
| Single pulse avalanche energy b | | | E _{AS} | 14 | mJ | |
| Maximum power dissipation | | | P_{D} | 62.5 | W | |
| Operating junction and storage temperature range | | | T _J , T _{stg} | -55 to +150 | °C | |
| Drain-source voltage slope | T _J = 125 °C | | d\//d+ | 70 | 1//22 | |
| Reverse diode dV/dt ^d | | | dV/dt | 0.13 | - V/ns | |
| Soldering recommendations (peak temperature) c | For 10 s | | | 300 | °C | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 140 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 0.9 A
- c. 1.6 mm from case
- d. $I_{SD} \le I_D$, $dI/dt = 100 \text{ A/}\mu\text{s}$, starting $T_J = 25 \,^{\circ}\text{C}$

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| THERMAL RESISTANCE RATINGS | | | | | |
|----------------------------------|-------------------|------|-----------|-------|--|
| PARAMETER | SYMBOL | TYP. | TYP. MAX. | | |
| Maximum junction-to-ambient | R _{thJA} | - | 62 | °C/W | |
| Maximum junction-to-case (drain) | R _{thJC} | - | 2.0 | G/ VV | |

| PARAMETER | SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|-----------------------|---|---|------|------|-------|------|
| Static | | | | | | | • |
| Drain-source breakdown voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 800 | - | - | V |
| V _{DS} temperature coefficient | $\Delta V_{DS}/T_{J}$ | Reference to 25 °C, I _D = 1 mA | | - | 1.0 | - | V/°C |
| Gate-source threshold Voltage (N) | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250 μA | | 2.0 | - | 4.0 | V |
| Gate-source leakage | I _{GSS} | $V_{GS} = \pm 20 \text{ V}$ | | - | - | ± 100 | nA |
| | | | V _{GS} = ± 30 V | - | - | ± 1 | μΑ |
| Zana anta calta na dunia accument | | V _{DS} = 800 V, V _{GS} = 0 V | | - | - | 1 | μА |
| Zero gate voltage drain current | I _{DSS} | V _{DS} = 640 \ | V _{DS} = 640 V, V _{GS} = 0 V, T _J = 125 °C | | - | 10 | |
| Drain-source on-state resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 1.0 A | - | 2.38 | - | Ω |
| Forward transconductance | 9 _{fs} | V _{DS} = 30 V, I _D = 1.0 A | | - | 1.0 | - | S |
| Dynamic | | | | | | | • |
| Input capacitance | C _{iss} | $V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ $f = 1 \text{ MHz}$ | | - | 315 | - | pF |
| Output capacitance | C _{oss} | | | - | 20 | - | |
| Reverse transfer capacitance | C _{rss} | | | - | 6 | - | |
| Effective output capacitance, energy related ^a | C _{o(er)} | V _{DS} = 0 V to 480 V, V _{GS} = 0 V | | - | 13 | - | |
| Effective output capacitance, time related ^b | C _{o(tr)} | | | - | 45 | - | |
| Total gate charge | Qg | | | - | 9.8 | 19.6 | |
| Gate-source charge | Q_{gs} | $V_{GS} = 10 \text{ V}$ $I_D = 1.0 \text{ A}, V_{DS} = 480 \text{ V}$ | | - | 2.4 | - | nC |
| Gate-drain charge | Q_{gd} | | | - | 3.9 | - | |
| Turn-on delay time | t _{d(on)} | | | - | 11 | 22 | ns |
| Rise time | t _r | V _{DD} = | V _{DD} = 480 V, I _D = 1.0 A, | | 7 | 14 | |
| Turn-off delay time | t _{d(off)} | $V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$ | | - | 19 | 38 | |
| Fall time | t _f | | | - | 27 | 54 | |
| Gate input resistance | R_g | f = 1 MHz, open drain | | 1.8 | 3.6 | 7.2 | Ω |
| Drain-Source Body Diode Characteristic | s | | | | | | |
| Continuous source-drain diode current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 2.8 | |
| Pulsed diode forward current | I _{SM} | | | - | - | 5 | A |
| Diode forward voltage | V _{SD} | T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V | | - | - | 1.2 | V |
| Reverse recovery time | t _{rr} | | | - | 278 | 556 | ns |
| Reverse recovery charge | Q _{rr} | T _J = 25 °C, I _F = I _S = 1.0 A, dl/dt = 100 A/ μ s, V _R = 25 V | | - | 0.9 | 1.8 | μC |
| Reverse recovery current | I _{RRM} | | | - | 5 | - | Α |

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

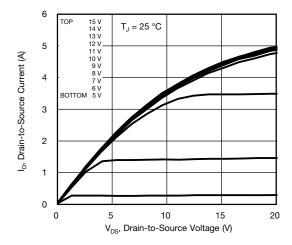


Fig. 1 - Typical Output Characteristics

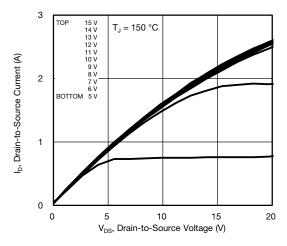


Fig. 2 - Typical Output Characteristics

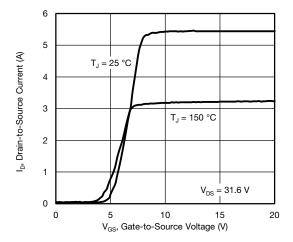


Fig. 3 - Typical Transfer Characteristics

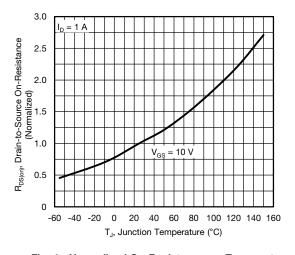


Fig. 4 - Normalized On-Resistance vs. Temperature

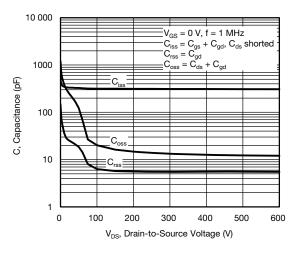


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

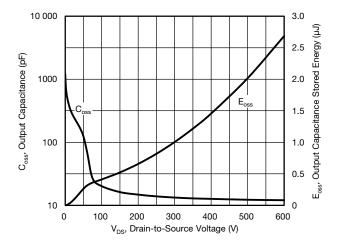


Fig. 6 - Coss and Eoss vs. VDS



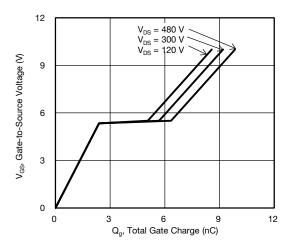


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

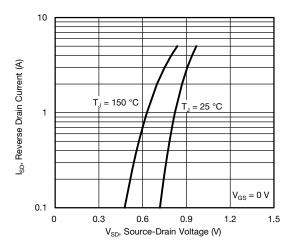


Fig. 8 - Typical Source-Drain Diode Forward Voltage

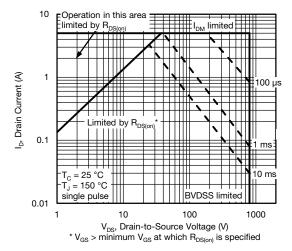


Fig. 9 - Maximum Safe Operating Area

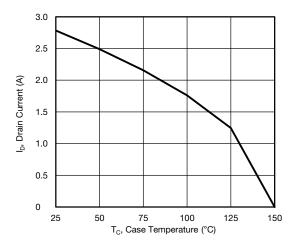


Fig. 10 - Maximum Drain Current vs. Case Temperature

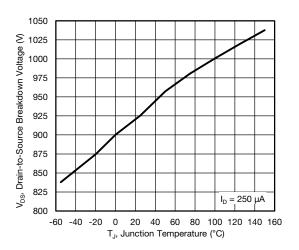


Fig. 11 - Temperature vs. Drain-to-Source Voltage



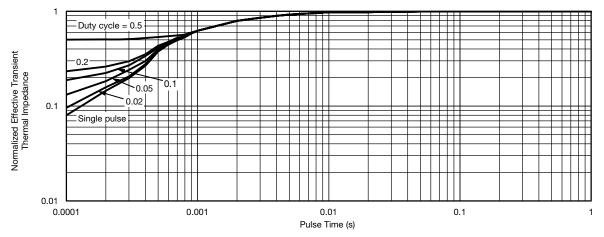


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

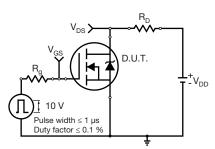


Fig. 13 - Switching Time Test Circuit

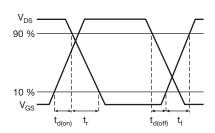


Fig. 14 - Switching Time Waveforms

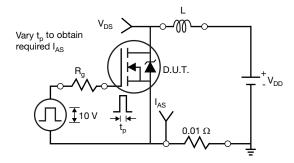


Fig. 15 - Unclamped Inductive Test Circuit

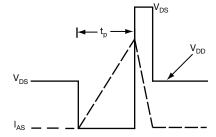


Fig. 16 - Unclamped Inductive Waveforms

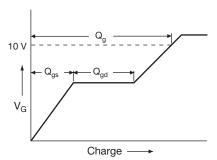


Fig. 17 - Basic Gate Charge Waveform

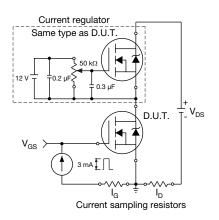
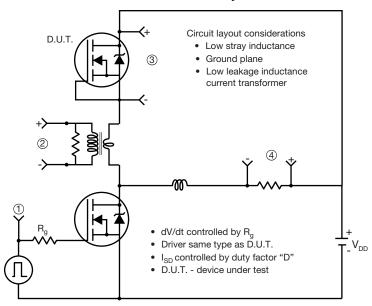


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



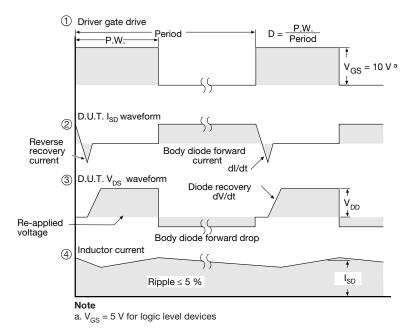


Fig. 19 - For N-Channel



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